## Application/Control No. 10/006,679 Applicant(s)/Patent Under Reexamination ARAKI ET AL. Examiner John P. Sheehan Applicant(s)/Patent Under Reexamination ARAKI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
·	Α	US-5,676,998	10-1997	Araki et al.	427/132
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	D	US-			
	E	US-			
	F	US-			
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## **NON-PATENT DOCUMENTS**

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